

| | | | | |
|-----------------------------------|--|---------------------------------------|--|-------------|
| Notice of References Cited | | Application/Control No. 10/580,167 | Applicant(s)/Patent Under Reexamination KATSUNAGA ET AL. | |
| | | Examiner Patricia T. Nguyen | Art Unit 2817 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | A | US-3,641,450 A | 02-1972 | Lunn, Gerald K. | 330/254 |
| * | B | US-5,642,077 A | 06-1997 | Nagaraj, Krishnaswamy | 330/253 |
| * | C | US-6,744,320 B2 | 06-2004 | Nguyen et al. | 330/254 |
| * | D | US-2006/0044064 A1 | 03-2006 | Pelleriti, Roberto | 330/254 |
| * | E | US-7,215,196 B2 | 05-2007 | Banba et al. | 330/254 |
| * | F | US-2007/0236289 A1 | 10-2007 | Iriguchi, Masao | 330/253 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.